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Effects of electron irradiation on the ferroelectric properties of Langmuir-Blodgett copolymer films

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The effect of irradiation on the ferroelectric properties of Langmuir-Blodgett films of the copolymer poly(vinylidene fluoride-trifluoroethylene) was investigated using 1-MeV electrons for doses from 0.16 to 1.10 MGy, where 1 Gray (Gy)=100 rad. Irradiation causes a systematic decrease in the phase-transition temperature, crystallinity, and spontaneous polarization of the films. The crystallinity and spontaneous polarization of the films decreased by amounts proportional to the dose, both tending toward zero near a dose of 1.30 MGy. The ferroelectric-paraelectric phase-transition temperature, however, was only reduced by about 12%, indicating that the primary effect of irradiation was to convert a crystalline ferroelectric material to a noncrystalline dielectric. © 2005 American Institute of Physics. [DOI: 10.1063/1.1954868]

INTRODUCTION

Polyvinylidene fluoride (PVDF) and its copolymers have long been studied for their striking ferroelectric properties and their applications in actuators, transducers, and ferroelectric memory. The homopolymer PVDF consists of a linear carbon-carbon chain with the repeating structure -(CH₂-CF₂)-, which has a permanent dipole moment roughly perpendicular to the chain. The ferroelectric phase consists of a polar crystalline packing of chains with all-trans conformation and an estimated polarization of 0.13 C/m². Though PVDF does not crystallize well from the melt, polymorphous samples containing lamellar crystals and amorphous material can be fabricated by solvent-casting or spin-coating techniques. Mechanical, thermal, and electrical treatment of the films can produce samples of about 50% crystallinity. Random copolymerization of PVDF with, e.g., 15% or more of trifluoroethylene (TrFE) suppresses the ferroelectric phase-transition temperature below the melting point, thus allowing samples to be annealed in the ferroelectric phase-transition temperature below the melting point. Crystalline PVDF copolymers show that irradiation with electrons of energy 1–3 MeV and a dose of 0.6 MGy (1 Gray=100 rad) converts the ferroelectric crystals to a combination of an amorphous material and a phase that is structurally similar to the paraelectric phase. The original ferroelectric state of the irradiated samples usually could not be recovered, even by long anneals above the paraelectric phase transition. Electron irradiation of PVDF-TrFE copolymer films near the ferroelectric-paraelectric phase-transition temperature results in conversion to a ferroelectric relaxorlike state, characterized by a giant electrostriction and high elastic energy density. The electron irradiation also results in the reduction of polarization hysteresis. This reduction in hysteresis, which is desirable for electromechanical devices, cannot be recovered by application of large fields and is therefore indicative of the permanent structural change. It has been proposed that radiation-induced double bonds stabilize the paraelectric phase. Cheng et al. report three dose ranges of interest. Range I, for doses <0.5 MGy, produces a mixture of polar and nonpolar phases. Range II, from 0.5 to 0.85 MGy, produces macroscopically uniform samples with little dielectric or thermal hysteresis, but a relaxorlike state indicating dipolar correlation even in nonferroelectric regions. Range III, above 1 MGy, produces a pre-

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It is well known that high-energy electron irradiation can have dramatic effects on the thermal, structural, and physical properties of PVDF and its copolymers. Electron irradiation lowers the melting point and the ferroelectric-paraelectric phase-transition temperature by reducing the crystallite size, introducing defects, reducing the strain in crystallite regions, and decreasing the dipolar energy. X-ray diffraction studies of vinylidene fluoride (VDF) copolymer samples show that irradiation with electrons of energy 1–3 MeV and a dose of 0.6 MGy (1 Gray=100 rad) converts the ferroelectric crystals to a combination of an amorphous material and a phase that is structurally similar to the paraelectric phase. The original ferroelectric state of the irradiated samples usually could not be recovered, even by long anneals above the paraelectric phase transition. Electron irradiation of PVDF-TrFE copolymer films near the ferroelectric-paraelectric phase-transition temperature results in conversion to a ferroelectric relaxorlike state, characterized by a giant electrostriction and high elastic energy density. The electron irradiation also results in the reduction of polarization hysteresis. This reduction in hysteresis, which is desirable for electromechanical devices, cannot be recovered by application of large fields and is therefore indicative of the permanent structural change. It has been proposed that radiation-induced double bonds stabilize the paraelectric phase. Cheng et al. report three dose ranges of interest. Range I, for doses <0.5 MGy, produces a mixture of polar and nonpolar phases. Range II, from 0.5 to 0.85 MGy, produces macroscopically uniform samples with little dielectric or thermal hysteresis, but a relaxorlike state indicating dipolar correlation even in nonferroelectric regions. Range III, above 1 MGy, produces a pre-
dominantly amorphous matrix with some embedded crystallites. Similarly, proton irradiation has also been shown to produce a relaxor-like state in VDF copolymers.14

The focus of this study is on the effect of irradiation on the ferroelectric properties of ultrathin (18–90 nm thick) films of the P(VDF-TrFE) copolymer. These films were produced by Langmuir-Blodgett (LB) deposition using methods developed by Palto et al. in 1995.15 The quality of these films is excellent, with high crystallinity and crystalline orientation,16 and they exhibit ferroelectric behavior in samples as thin as 1 nm.17 The ferroelectric properties of the LB copolymer films—the phase-transition temperature, the spontaneous polarization, and the piezoelectric and pyroelectric responses16,17—are similar to those of films made by solvent spinning.2 The switching characteristics of the LB films, however, are fundamentally different. They have much higher coercive fields,18 about 500 MV/m vs 50 MV/m for solvent-formed films,19 and switching is much slower,20 more than 10 s vs less than 1 μs.21 The present study reveals some of the effects of electron irradiation on the properties of the LB films, particularly on the crystallinity, transition temperature, polarization, and switching characteristics.

EXPERIMENTAL METHODS

The samples consisted of capacitors containing LB films of P(VDF-TrFE) 70:30 copolymer. The substrates were 0.15-mm-thick glass slides on which two 50-nm-thick, 1-mm-wide strip aluminum electrodes were evaporated. The 70:30 copolymer was deposited to the desired thickness by a method based on LB deposition, as described in detail elsewhere.15,22,23 Briefly, in this method, a 0.1 wt % copolymer solution in dimethylsulfoxide (DMSO) is dispersed onto the surface of a trough of water at room temperature. Barriers on the water’s surface slowly compress the copolymer to a surface pressure of 5 mN/m, which is well below the collapse pressure. At this pressure, we have found that the deposited LB films were uniform and highly oriented. After deposition, another set of identical top aluminum strip electrodes oriented 90° with respect to the bottom electrodes were evaporated, allowing four independently addressable capacitors per sample. Twenty-four samples were used in this study: three 10-layer samples (18 nm thick), eighteen 20-layer samples (36 nm), and three 50-layer (90 nm) samples. The samples were annealed at 120 °C for 2 h prior to irradiation to improve crystallinity, resulting in uniform films with high crystallinity and orientation. Each sample was characterized prior to irradiation by measuring the thermal hysteresis, the coercive voltage, and the remanent polarization. The sample capacitance, which is proportional to the dielectric constant, was measured using an impedance analyzer (Hewlett-Packard 4192A)24 at 1-kHz frequency and 0.1-V amplitude. The capacitance was recorded as a function of temperature during heating and cooling at a rate of 1 °C/min to characterize the ferroelectric-paraelectric and paraelectric-ferroelectric phase transitions, respectively. The capacitance was recorded as a function of the voltage bias cycled at a rate of 0.05 V/s to characterize polarization switching.

The remanent polarization and switching characteristics were measured by the Merz and Chynoweth methods, respectively.25,26 The switched charge was determined by the Merz method, in which a sinusoidal or triangular voltage wave form was applied to a sample and the resulting current through the sample was measured. The current due to polarization switching appeared as a peak in excess of the usual capacitor discharge current, and the area of this peak equals twice the switched polarization. The Merz measurements were performed by applying triangular wave forms with amplitudes from 12 to 18 V at each of three different frequencies (0.1, 1, and 100 Hz) and recording the voltage across a fixed resistor connected in series with the sample. The Merz measurements were made both before and after irradiation. The Chynoweth method allows one to measure the pyroelectric response, which is proportional to the net sample polarization, by measuring the polarization current due to a small laser-induced thermal modulation. The Chynoweth pyroelectric measurements were made with a 5-mW He-Ne laser chopped at 2 kHz and the resulting ac was recorded by a digital lock-in amplifier (Stanford Research Systems SR830). To record the polarization hysteresis loops, an electrical bias voltage was applied to the sample for 1 min, then the bias was removed and the sample was connected to the current inputs of the lock-in amplifier. The sample was illuminated with the modulated laser beam and the resulting ac current was measured at zero voltage by the lock-in amplifier and was allowed to stabilize for 5 min. This was repeated as the applied voltage was cycled stepwise. The polarization retention measurements also used this same method, except that the polarization was saturated by applying a steady voltage of either ±20 V for 1 h and then the pyroelectric current was measured continuously for up to 36 h. The Chynoweth pyroelectric measurements were made only after irradiation.

Film crystallinity was measured by x-ray diffraction using a Rigaku θ-2θ diffractometer with Cu Kα (1.54 Å) radiation to measure the lattice spacing perpendicular to the film.

IRRADIATION

Irradiation of the samples was performed at the National Institute of Standards and Technology using a Van de Graaff electron accelerator. The samples were arranged in three identical vertical stacks of eight samples each and irradiated in a nitrogen atmosphere at room temperature. In this configuration, both exposure and electron energy will decrease as the beam passes through the stack. The beam area was 7.62 × 7.62 cm², which was large enough to simultaneously irradiate all three sample stacks with ±5% lateral beam uniformity. This configuration allowed for irradiation of a large number of samples with a broad range of doses, from 0.16 to 1.10 MGy, to be obtained under uniform conditions. Because of the sample configuration, doses were only measured directly for the top samples, then calculated for lower samples by the method described below.

The sample chamber was mounted with the substrates oriented horizontally in vertical stacks 28 cm below the Van de Graaff exit window, so that the electron beam was inci-
SAMPLE DOSE DETERMINATION

Doses of the samples were determined using a combination of experimental and computational techniques. The experimental dose of the top sample was measured using radiographic dye dosimeters, 1.0-cm square and 50 µm thick. These dosimeters consist of a nylon matrix incorporating an organic dye in the form of a thin solid film. They are well characterized, yield reproducible results, and come in a convenient form for measuring sample doses in the range of 1–50 kGy. Rather than placing a dosimeter film at each sample position, it was decided to measure the dose of the top sample layer, as it enters the sample stack. At this energy, a reasonable dose gradient was achieved while still giving a significant dose to the samples at the bottom of the stacks. All three stacks were present at the beginning of exposure and were removed one at a time as each received the desired dose. The stack ordering and doses are given in Table I.

RESULTS

Figure 2 shows the thermal hysteresis in the capacitance for three 20-layer samples that received different doses. The dielectric peaks on heating and cooling correspond to the ferroelectric-paraelectric and reverse transitions, respectively. Irradiation results in a monotonic downward shift for both transition peaks, as shown in Fig. 3, at a rate of −46 °C/MGy for the heating peaks and −57 °C/MGy for the cooling peaks up to a dose of 0.60 MGy. These transition

FIG. 1. Calculated relative dose and beam energy as a function of sample position. The electron beam strikes sample 1 first in each stack.

FIG. 2. Capacitance measurements showing thermal hysteresis for three of the 20-layer samples receiving different electron-beam doses, as labeled next to the curves. Notice the downward shift in the heating and cooling phase-transition peaks and the virtual elimination of thermal hysteresis accompanied by peak broadening at 1.04-MGy dose.
temperature suppression rates are comparable to those obtained from studies of thicker spun-cast and hot-pressed VDF copolymer films.\textsuperscript{7,11,12} There is a significant thermal hysteresis evident for 20-layer samples receiving doses up to 0.90 MGy, and up to 1.08 MGy for the 50-layer samples. Higher doses eliminate thermal hysteresis. The suppression may begin to plateau, as seen by Cheng \textit{et al.},\textsuperscript{11} for doses higher than 0.70 MGy. However, this issue is confounded by the increase in the fraction of the amorphous material, which is evident in the broadening of the phase-transition peak for high doses (see Fig. 2 for 1.04-MGy dose). The dielectric peak for 1.04 MGy may no longer be due to a true ferroelectric-paraelectric phase transition, but may result from a dielectric anomaly in the amorphous regions. Both Lovinger\textsuperscript{12} and Daudin \textit{et al.}\textsuperscript{7} reported a linear decrease of $T_C$ with increased electron dose. Lovinger’s differential scanning calorimetry (DSC) data, in particular, shows no discernible phase transition above 1.0-MGy dose using 3-MeV electrons.

Figure 4 shows the capacitance, $C(E) \propto dD/dE$, “butterfly” curves for three 20-monolayer samples receiving different electron doses. The butterfly curves show peaks near the coercive voltage, the voltage at which the spontaneous polarization reverses direction.\textsuperscript{30} The coercive voltage is shown to decrease with increased dose at a rate of $\approx 2.2$ V/MGy, as shown in Fig. 5. The amount of hysteresis in the butterfly curves also decreases with increased dose, which is likely due to a decrease in the remanent polarization. The values of capacitance do not show a clear dependence on dose, and any differences seen are likely due to sample variation. Just like the thermal dielectric peak, this measurement is also sensitive to the dielectric response of the amorphous material, and therefore the peak voltage given by this measurement may not correspond to the true coercive voltage of the ferroelectric material, especially for higher doses.

The dielectric measurements can be influenced strongly by a relaxorlike behavior, as has been shown by Zhang and co-workers,\textsuperscript{9–11} and therefore the coercive voltage and the remanent polarization were independently measured using the Chynoweth pyroelectric technique.\textsuperscript{26} The pyroelectric current is directly proportional to the net polarization in the film,\textsuperscript{31} and probes only the ferroelectric phase unlike the capacitance, which includes contributions from all crystalline and amorphous phases. Figure 6(a) shows the pyroelectric hysteresis loops for samples of different doses. The coercive voltage was determined from the pyroelectric hysteresis loops by taking half of the difference between the intercept voltages. The coercive voltages shown in Fig. 5 indicate that the switching characteristics of the films have been affected by irradiation. The butterfly capacitance measurements include contributions from amorphous and crystalline materials of any phase, not just the ferroelectric material. The pyroelectric measurements are sensitive to only the ferroelectric crystalline material, but the present data cannot determine whether the changes are due to the presence of...
increased amorphous material, the reduction of ferroelectric crystal size, increased strain, or to an interaction between the amorphous and crystalline regions. The saturated maximum pyroelectric signal is found to decrease monotonically with increasing dose at a rate of −83% /MGy, as shown in Fig. 7. Polarization values obtained from the Merz data [Fig. 6(b)] revealed a similar reduction in the polarization, but a lower rate of −60% /MGy. The Merz measurements are dynamic measurements made at 1 Hz, cycled much faster than the butterfly or pyroelectric measurements, and may not include the total switched charge due to dispersion in the switching times across the film. The presence of repeatable hysteresis indicates that a ferroelectric material is present in all the irradiated films up to at least 0.90 MGy, although the remnant polarization of the samples was greatly reduced. Furthermore, samples receiving up to 0.90-MGy dose maintained stable polarization for at least 36 h, after an initial decay of 30%–50% in the first 5 min. This initial decrease may indicate the presence of trapped charge or crystallites with unstable polarization.

The θ-2θ x-ray diffraction measurements show the (110) peak normal to the film. For the ferroelectric phase, the (110) peak is located near 19.5°, corresponding to a layer spacing of 4.5 Å, while the (110) paraelectric phase peak is located near 18°, corresponding to a spacing of 4.9 Å.16,32 Figure 8(a) shows the x-ray diffraction measurements recorded at room temperature and at 100 °C for the 20-layer films of different doses. At 100 °C, the unirradiated sample shows both ferroelectric and paraelectric peaks, indicating that the sample is still in a mixed phase, which is consistent with the fact that its dielectric peak on heating is at 100 °C (see Fig. 3). The irradiated samples exhibit only the paraelectric x-ray diffraction (XRD) peak at 100 °C, because their transition temperatures have been suppressed, and no ferroelectric phase remains at this temperature. The room-temperature measurements show the gradual conversion of the sample from the ferroelectric phase to the paraelectric phase. Figure 8(b) shows the (110) d spacings of the films plotted as a function of dose. The ferroelectric β-phase peak decreases to...
zero at approximately 0.55 MGy and is partially replaced by a spacing near the paraelectric phase spacing. The total integrated intensity of the ferroelectric and paraelectric peaks decreases to zero at approximately 1.20 MGy, which implies that the material is almost completely amorphous, though it does not rule out the presence of crystallites with a different orientation. The presence of the paraelectric phase at room temperature is in contrast with the thermal hysteresis found in the capacitance versus temperature measurements and polarization hysteresis measurements, which would indicate that there is a substantial ferroelectric material at room temperature, even up to 0.90-MGy exposure. It has been suggested that at room temperature, the ferroelectric regions are too small to be seen in x-ray diffraction, which places a maximum size of 5 nm on the ferroelectric crystallites at 0.50 MGy.\textsuperscript{11} This seems unlikely in this case, however, if one considers the correlation between the crystallinity and remanant polarization on irradiation dose, as shown in Fig. 7. The crystallinity decreases at a rate of $-72\%$ /MGy, while the net pyroelectric signal decreases at a rate of $-85\%$ /MGy. This linear decrease in polarization was also observed in the total switched charge calculated from the Merz measurements, as shown in Fig. 6(b). The correlation between polarization and crystallinity indicates that most or all of the remaining crystalline material is also polarizable under an electric field, and hence ferroelectric. Previous studies have shown a large reversion of paraelectric material to ferroelectric material under an electric field, which may be partially responsible for the giant electrostriction following electron irradiation of these materials.\textsuperscript{11} However, the small area of our electrodes makes this observation difficult to quantify because the area of our x-ray beam is about 100 times larger than our electrode area.

CONCLUSIONS

The present results indicate that irradiation mainly reduces sample crystallinity. The remaining ferroelectric material has a slightly reduced transition temperature, though a combination of thermal annealing and poling is sufficient to return the crystalline fraction to the ferroelectric phase at room temperature. The strong dielectric nonlinearity and hysteresis evident in the butterfly curves of the highly irradiated samples suggest that the amorphous material is primarily responsible for a relaxorlike behavior observed with solvent-formed copolymer films, which exhibit large electrostriction after doses in the range from 0.6 to 0.8 MGy.\textsuperscript{9,11} A measurement of the electrostriction in the irradiated LB films is needed to test this hypothesis.

Future studies should focus on determining the types and amounts of defects acquired during irradiation and on the effect of irradiation on electrostriction and switching kinetics. Electrostriction measurements correlated with crystallinity and remanant polarization are necessary to confirm the assumption that phase conversion is the primary cause of large electrostriction in P(VDF-TrFE). Identifying the types of defects will give insight to the reduction in the phase-transition temperature and the relaxation of the crystal structure. This identification may also help identify the cause of the increase in coercive field above 0.5 MGy and aid in determining whether these defects impede or enhance the switching characteristics of the LB films.

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